


<b>Search Notes</b>  	<b>Application/Control No.</b>  10528445	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL
	<b>Examiner</b>  Hanh Phan	<b>Art Unit</b>  2613

SEARCHED			
Class	Subclass	Date	Examiner
398	182, 183, 186, 184, 192, 193, 194, 195, 196, 197, 198, 199, 200, 201, 79, 66, 67, 68, 70, 71, 72, 33, 202, 208, 209, 91, 92, 93, 95, 94	05/08/2008	HP
UPDATE SEARCH		05/08/2008	HP

SEARCH NOTES			
Search Notes		Date	Examiner
EAST SEARCH SEE ATTACHED PRINTOUT IN THE FILE		05/08/2008	HP
IEEE SEARCH		05/08/2008	HP
JPO SEARCH		05/08/2008	HP
PGPUB TEXT SEARCH SEE INTERFERENCE SEARCH PRINTOUT		05/08/2008	HP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
398	182, 183, 184, 186, 192, 193, 194, 195, 196, 197, 198, 200, 201, 199, 79, 66, 67, 68, 70, 71, 72, 91, 92, 93, 94, 95, 202, 298, 209	05/08/2008	HP